SERIAL NO. ATTY. DOCKET NO. INFORMATION DISCLOSURE CITATION 10/762.066 15437-0598 IN AN APPLICATION APPLICANT: (PTO-1449) Ozgur C. Leonard et al APR 1 8 2006 **FILING DATE: GROUP:** 2171 January 20, 2004 TRADE **U.S. PATENT DOCUMENTS** U.S. Patent Document Name of Patentee or Applicant Date of Publication of Pages, Columns, Exam. Cite of Cited Document Cited Document Lines, Where Initial* No. Number Kind Code² MM-DD-YYYY Relevant (If known) Passages or Relevant Figures Appear 2002/0161817 Dorofeev et al. 10-31-2002 Αl

Exam.	Cite	Foreign Patent Document			Name of Patentee or Applicant	Date of	Pages,	Т6
Initial*	No.'	Office ³	Number ⁴	Kind Code ³ (If known)	of Cited Document	Publication of Cited Document MM-DD-YYYY	Columns, Lines, Where Relevant Passages or Relevant Figures Appear	

		OTHER ART - NO PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	Translation ²

Examiner	1711	Date Considered
Signature	E Meuse	7/6/06

¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code (WIPO Standard S.3). ⁴For Japanese patent documents, the indication of the year of reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶Applicant is to place a check mark here if English language Translation is attached.

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

INF	OR	RM.				SUR CATIO	E CITATION	ATTY. DOCKE 15437-0598	T NO.		AL NO	
	/	SIF	E	ФΤ)-14 ⁴		51 1	APPLICANT: Ozgur C. Leon	ard, et al.			
	JA	n 1	6 2006 E	ه . پر				FILING DATE: GRO January 20, 2004 217			OUP: '1	
	(B).						U.S. PATENT DOCU	MENTS				
Exam. Initial*	tial* No. Number Kind		Kind	Code ² known)	Name of Patentee or Applicant of Cited Document		Date of Publication Cited Document MM-DD-YYYY	,	Pages, Col Lines, W Releva Passage Relevant F Appe			
Exam. Initial*	Exam. Cite Foreign Patent Document		ent d Code ⁵	4	OCUMENTS tee or Applicant Document	Date of Publication of Cited Document MM-DD-YYYY	Col Lines Re Pass Re Fi	ages, umns, , Where levant ages or levant gures	T ⁶			
		\dashv	ï			<u> </u>				A	opear	
Examir	ner	Cite	In	clude nan	ne of th	e author (– NO PATENT LITEI	title of the article (wh	en appropriate), title o	f the	Transla	ıtion²
Initials	s*	No¹	ite	m (book,	magazi	ne, journ	al, serial, symposium, cata publisher, city and/or coun	og, etc.), date, page(s	s), volume-issue numbe	er(s),		_
Elet	//						O for foreign patent ags) – attached.	pplication no. 04	252 690.5 - 2211 c	lated		
Elet				rrent Cla	aims i	n EPO	patent application no.	04 252 690.5 - 22	211 (<u>\$</u> pgs) –			

Examiner Signature

Date Considered

¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code (WIPO Standard S.3). ⁴For Japanese patent documents, the indication of the year of reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶Applicant is to place a check mark here if English language Translation is attached.

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

INF	CARING SEP 1	ATION DISC IN AN APP (PTO	E CITATION ON				SERIAL NO. 10/762,066		
	SATENT & I	LJ/			FILING DATE: January 20, 2004	4	GRC 217	DUP: 1	
				U.S. PATENT DOCU	MENTS				
Exam. Initial•	Cite No. ¹	U.S. Patent Do	Kind Code ² (If known)	Name of Patentee of Cited Do		Date of Publication Cited Document MM-DD-YYYY	1	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
Elek	1	2002/0156824	A1	Armstron	g et al.	10-24-2002			

	FOREIGN PATENT DOCUMENTS												
Exam. Initial*	Cite No.1	Office ³	Number ⁴	Document Kind Code ⁵ (If known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶					
ELIK		EP	130076	6 A	Sun Microsystems Inc.	04-09-2003							
		 	 					 					

	· · · · · · · · · · · · · · · · · · ·	OTHER ART – NO PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	Translation ²
Ell		EUROPEAN PATENT OFFICE, "European Search Report," application No. 04252689.7, mailing date July 28, 2005, 3 pages.	
1		Current Claims, European patent application 04252689.7, 6 pages.	
		SUN MICROSYSTEMS, "Sun EnterpriseTM 1000 Server: Dynamic System Domains," White Paper Online, February 26, 2003, retrieved from the internet at http://www.sun.com/servers/highend/whitepapers/domains.html?facet=-1 , retrieved on 06/21/2005, XP-002332946, 7 pages.	

·				
Examiner	1971	. 1/	Date Considered	
· ·		/ W		
Signature	1 7 7 1	The boards	1 7/6/06	1
Oignature	<u> </u>	// CUCIXI		1
				_

[•]EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code (WIPO Standard S.3). ⁴For Japanese patent documents, the indication of the year of reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶Applicant is to place a check mark here if English language Translation is attached.

	SEP OF	ATION DISCLO LAN APPLIO 700-14	CATION	CITATION	ATTY. DOCKET 15437-0598 APPLICANT: Ozgur C. Leon	SERIAL NO. 10/762,066	
ART	& TRADE	MARK C.			FILING DATE: January 20, 200	GROUP: 2171	
			U.S	S. PATENT DOCU	MENTS		
Exam. Initial*	Cite No.1	U.S. Patent Documen		Name of Patentee or Applicant of Cited Document		Date of Publication	
			Code ² known)			MM-DD-YYYY	
			<u></u>			<u> </u>	

Exam.	Cite	Foreign Patent Document			Name of Patentee or Applicant	Date of	Pages,	Т6
Initial*	No.'	Office ³	Number ⁴	Kind Code ⁵ (If known)	of Cited Document	Publication of Cited Document MM-DD-YYYY	Columns, Lines, Where Relevant Passages or Relevant Figures Appear	•

	1	OTHER ART – NO PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	Translation ²
Elek		Official Action from EPO for foreign patent application no. 04 252 690.5 - 2211 dated 10 June 2005 (6 pgs) – attached.	
Elek		Current Claims in EPO patent application no. 04 252 690.5 - 2211 (9 pgs) - attached.	-

Examiner	CD 11		Date Considered	H	1, 1	
Signature	EM	RUX	1	17/	61	0h

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code (WIPO Standard S.3). ⁴For Japanese patent documents, the indication of the year of reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶Applicant is to place a check mark here if English language Translation is attached.

INFORMATION DISCLOSURE CITATION OF AN APPLICATION

(PTO-1449)

ATTY. DOCKET NO. SERIAL NO. 15437-0598 10/762,066

APPLICANT:

Ozgur C. Leonard, et al.

FILING DATE: January 20, 2004 **GROUP:** 2171

Exam. Initial*	Cite No.1	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document	Pages, Columns, Lines, Where
		Number	Kind Code ² (If known)		MM-DD-YYYY	Relevant Passages or Relevant Figures Appear
Elok)	/	5,325,526		Cameron, et al.	6/28/1994	
ZAMU	_	5,845,116		Saito, et al.	12/1/1998	
1/		5,437,032		Wolf, et al.	6/25/1995	
Ч-						

	_,			FO	REIGN PATENT DOCUMENTS			
Exam. Initial*	Cite No. ¹	Fo Office ³	oreign Patent I Number ⁴	Occument Kind Code ⁵ (If known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
Eliki		EP	122803	8 A2	Tanaka, Katsuyoshi	2/5/2003		<u> </u>
Elek	/	EP	104365	8 A1	Rogier, Pierre	10/11/2000		

Examiner Initials*	Cite No ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	Translation ²
Elek		European Search Report from the European Patent Office for Foreign Patent Application No. 04252690.5 (3 pgs.)	
GOR,		Claims As Filed in European Patent Application No. 04252690.5 (6 pgs.)	

Examiner Signature	& Plekpuse	Date Considered 4/	6/06
			7

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code (WIPO Standard S.3). ⁴For Japanese patent documents, the indication of the year of reign of the Emperor must precede the serial number of the patent document. ³Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶Applicant is to place a check mark here if English language Translation is attached.

6	PE	IATION DIS		ATTY. DOCKET NO. 15437-0598 APPLICANT: Ozgur C. Leonard, et al.				
Exam.	217	in i			FILING DATE: 1/20/2004	iu, ot ui.	GROUP: NYA	
SAS		MARI		U.S. PATENT DOCU	MENTS			
Exam. Initial*	Cite No.'	U.S. Patent I Number	Cocument Kind Code ² (If known)	Name of Patentee of Cited Do	or Applicant	Date of Publication Cited Document MM-DD-YYYY	Lines, V	Vhere ant es or Figures
FUN		6,074,427		Fought	et al.	6/13/2000		
·								
								
			_					
						<u> </u>		
			0		· · · · · · · · · · · · · · · · · · ·			
								
· · · · · · · · · · · · · · · · · · ·			Tr/	OREIGN PATENT DO	CUMENTS			
Exam. Initial*	Cite No.	Foreign Patent Office ³ Number ⁴		Name of Pater	ntee or Applicant Document	Date of Publication of Cited Document	Pages, Columns, Lines, Where Relevant	T ⁶

				FO	REIGN PATENT DOCUMENTS			
Exam.	Cite	Foreign Patent Document			Name of Patentee or Applicant	Date of	Pages,	т6
Initial*	No.	Office ³	Number ⁴	Kind Code ⁵ (If known)	of Cited Document	Publication of Cited Document MM-DD- YYYY	Columns, Lines, Where Relevant Passages or Relevant Figures Appear	1
						<u> </u>		
								1

Examiner	247 8.1	Date Considered	4/1/
Signature	6 8 Met pur		7/6/06
EVALORED I SEL			

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code (WIPO Standard S.3). ⁴For Japanese patent documents, the indication of the year of reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶Applicant is to place a check mark here if English language Translation is attached.

101	PEG			ATTY. DOCKET 15437-0598 APPLICANT: Ozgur C. Leona			RIAL NO. 762,066	
APR 2 6 2004 E					FILING DATE: January 20, 200	4	GRO NY A	
Exam. Initial*	Cite No.	U.S. Patent Document		Name of Patentee of Cited Do	or Applicant	Date of Publication Cited Document MM-DD-YYYY		Pages, Columns, Lines, Where Relevant Passages or Relevant Figures

Exam.	Cite			Foreign Patent Document		Document	Name of Patentee or Applicant	Date of	Pages,	Т(
Initial*	No.¹	Office ³	Number ⁴	Kind Code ⁵ (If known)	of Cited Document	Publication of Cited Document MM-DD-YYYY	Columns, Lines, Where Relevant Passages or Relevant Figures Appear	•		
			1							

Examiner Initials*	Cite No ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	Translation ²
Elek		POUL-HENNING KAMP, et al., "Jails: Confining the omnipotent root", 2 nd Intl System Administration and Networking Conference Proceedings "SANE 2000", May 22-25, 2000, Maastricht, The Netherlands, pp. 1-11.	

Examiner Signature	EPUL DOLAR	Date Considered	1/6	106
			10	VV

¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code (WIPO Standard S.3). ⁴For Japanese patent documents, the indication of the year of reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶Applicant is to place a check mark here if English language Translation is attached.

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.